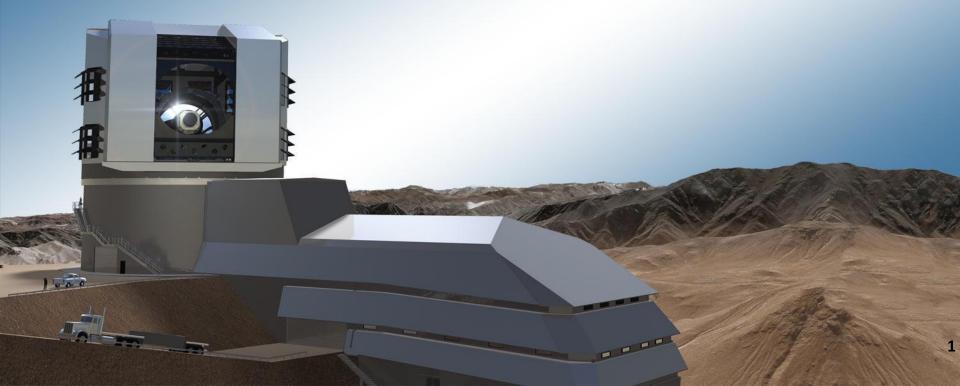


Deferred Charge and Serial Traps

Adam Snyder LSST PCW 8/13/2019





Effects dependent on number of transfers:

- Transfer due to self-induced drift, fringing fields, and diffusion
- Uniformly distributed single electron traps
 - Bulk traps
 - Radiation-induced traps

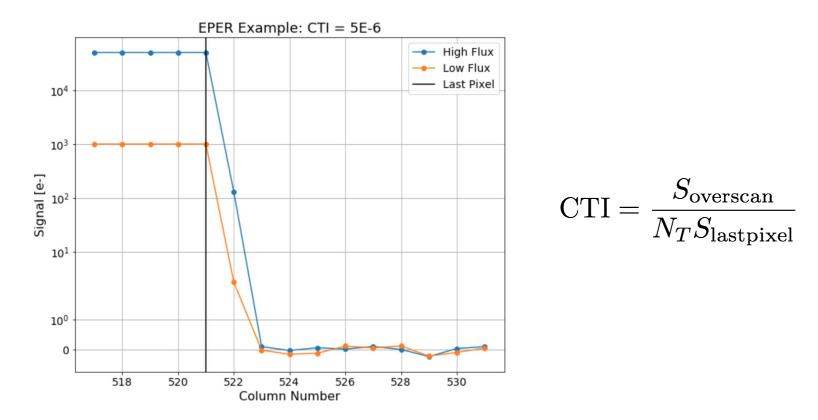
Effects independent on number of transfers:

- Design traps fixed charge loss of up to O(100) e-
- Process traps fixed charge loss of O(10) e-
- Electronic effects
 - Drifting bias offset
 - Incomplete reset of the sense node



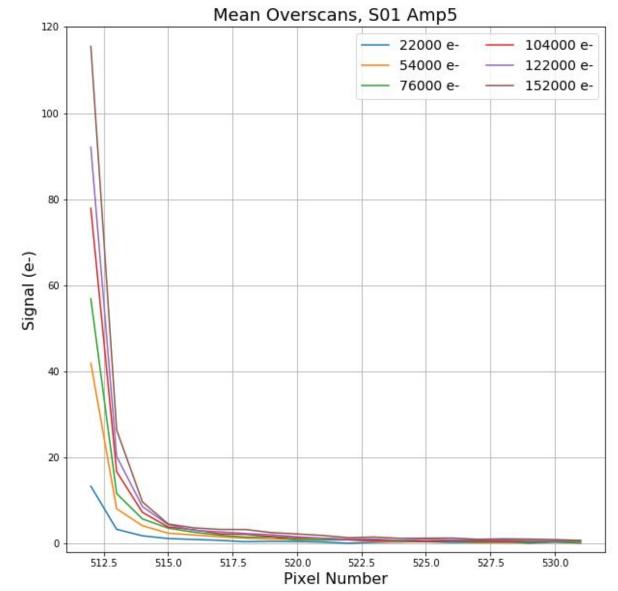
<u>Charge Transfer Inefficiency (CTI)</u> - ratio of electrons not transferred between two pixels, to the total electrons before the transfer.

<u>Extended Pixel Edge Response (EPER)</u> - measurement of deferred charge in the overscan pixel region, after a flat field image.



ITL Deferred Charge





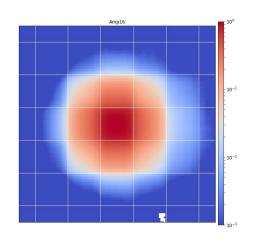
At high fluxes, deferred charge signal measured in overscan traces.

ITL Deferred Charge



CTI from EPER, S01 10^{-4} 10^{-5} Ð 10^{-6} 10^{-7} 10⁵ 10² 10³ 104 flux (e-)

Aggregated Fe55 Profile:



At low fluxes, significant deferred charge is measured in several CCD amplifier segments.

Can this effect be modeled/simulated/corrected?



CTI Correction (R. Massey 2009)

- True Image = I
- Image after readout =
- Image after additional readout
- (A) + (A) (B)
- After additional readout
- (A) + (C) (D)

 $I + \delta$ (A) $I + 2\delta + \delta^2$ (B) $I - \delta^2$ (C)

$$I+\delta-\delta^2-\delta^3$$
 (D)

$$_{I\,+\,\delta^{3}}$$
 (E)

Additional considerations needed for noise correlations introduced by repeated simulated serial transfers.

=

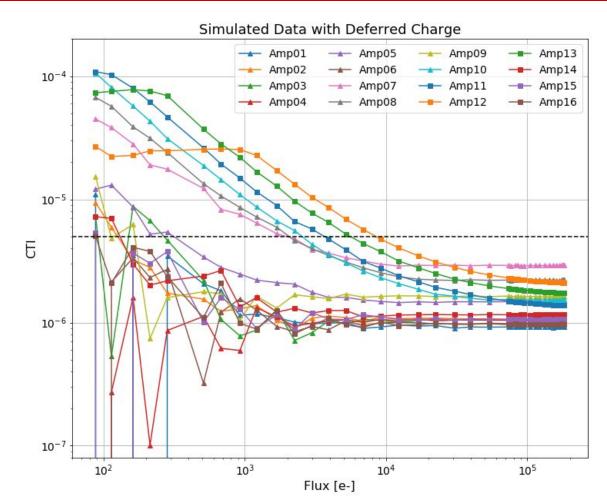
=

=

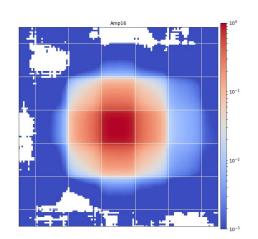
=

Simulated Deferred Charge





Aggregated Fe55 Profile:



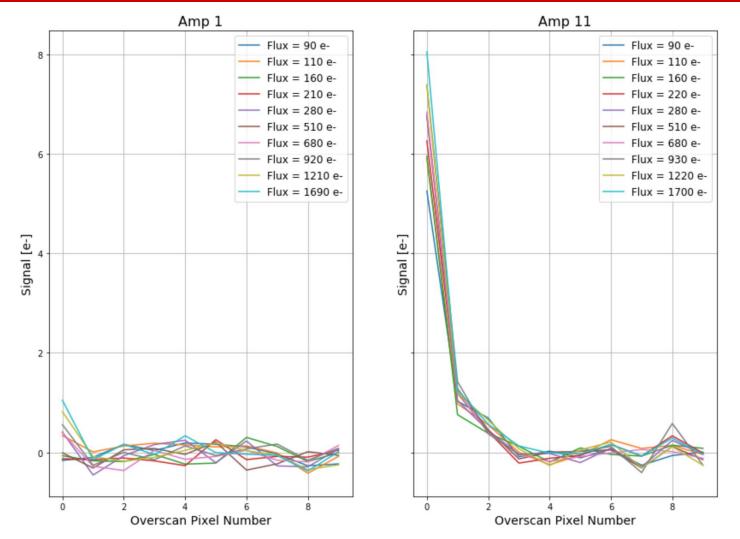
Simulate images with serial readout including:

- Pixel-to-pixel percentage charge inefficiency
- Serial register trapping (MCMC determined trap parameters)

Back-Up Slides

ITL Deferred Charge

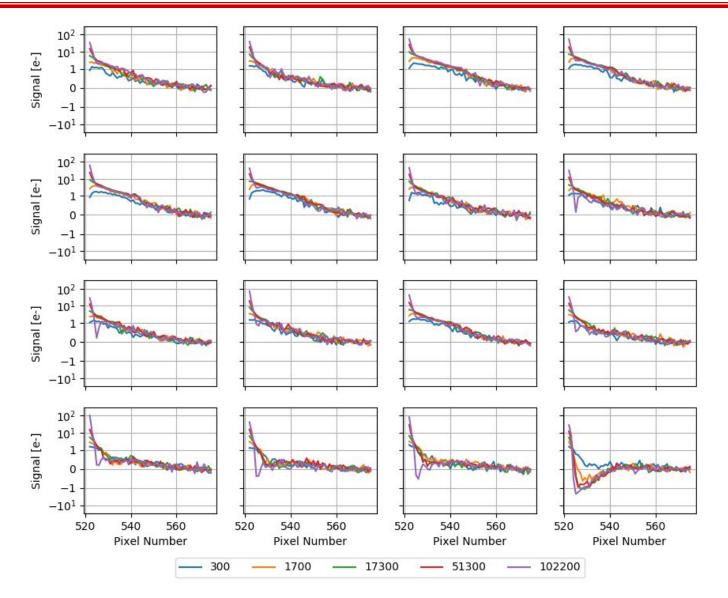




Comparison of two amplifiers, showing large CTI discrepancies at low flux.

E2V Deferred Charge

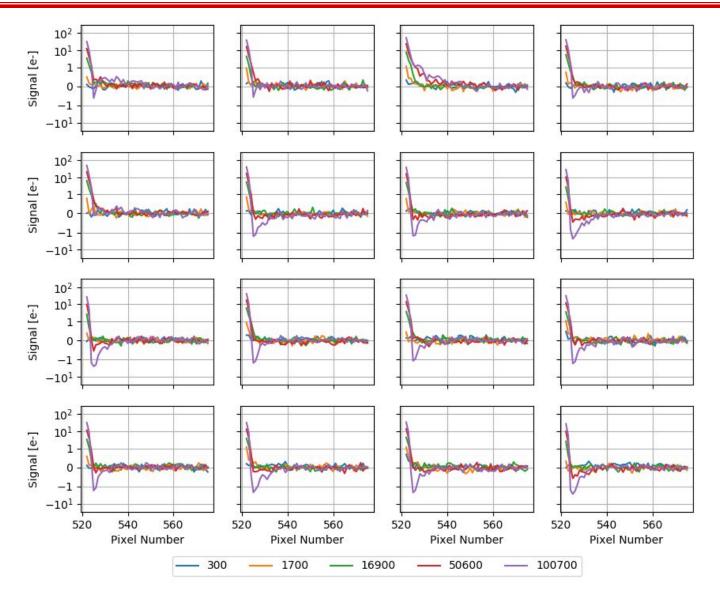
Large Synoptic Survey Telescope



Deferred charge signal initially seen in overscan traces.

E2V Deferred Charge

Large Synoptic Survey Telescope



Adjusting reset gate voltage removes signal (but negative bounce remains).